

# Search Notes



Application/Control No.

10/734,297

Examiner

Tae H. Yoon

Applicant(s)/Patent under Reexamination

OHGANE ET AL.

Art Unit

1714

## SEARCHED

Class	Subclass	Date	Examiner
524	494	8-18-06	Y
	430		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST Inventory Search	8-27-06	Y